Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/643,224	SAJIMA ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1732	

SEARCHED					
Class	Subclass	Date	Examiner		
UPDATED	UPDATED	7/7/2006	EHL		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
264	161,162	7/7/2006	EHL		
	320,279.1				
425	116,408				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
UPDATED	7/7/2006	EHL		
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